Application/Control No. Applicant(s)/Patent Under Reexamination 10/045,674 LADNER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1639 Jon D. Epperson **U.S. PATENT DOCUMENTS Document Number** Date Name Country Code-Number-Kind Code Classification MM-YYYY US-Α US-В US-С US-D US-Ε US- -F US-G Н US-USı US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY WO 94/07922 04-1994 **WIPO** Ν Burton et al. C07K 15/28 0 Ρ Q R s Т **NON-PATENT DOCUMENTS**

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